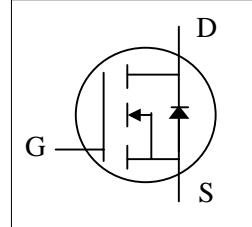
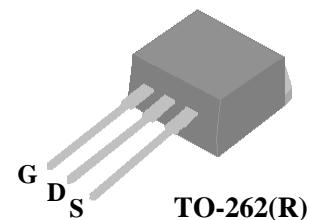




- ▼ 100% Avalanche Test
- ▼ Fast Switching Characteristic
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant & Halogen-Free



$BV_{DSS}$	600V
$R_{DS(ON)}$	0.6Ω
$I_D$	10A



## Description

AP3990 series are from Advanced Power innovative design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The TO-262 package is widely preferred for commercial-industrial through-hole applications and suited for low voltage applications such as DC/DC converters.

## Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	600	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D @ T_C = 25^\circ\text{C}$	Drain Current, $V_{GS} @ 10\text{V}$	10	A
$I_D @ T_C = 100^\circ\text{C}$	Drain Current, $V_{GS} @ 10\text{V}$	6.5	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	40	A
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation	174	W
$E_{AS}$	Single Pulse Avalanche Energy <sup>2</sup>	50	mJ
$I_{AR}$	Avalanche Current	10	A
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Value	Unit
$R_{thj-c}$	Maximum Thermal Resistance, Junction-case	0.72	°C/W
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient	62	°C/W



## Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=1.0\text{mA}$	600	-	-	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance <sup>3</sup>	$V_{\text{GS}}=10\text{V}$ , $I_D=5.0\text{A}$	-	-	0.6	$\Omega$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_D=250\mu\text{A}$	2	-	4.5	V
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=10\text{V}$ , $I_D=5\text{A}$	-	5	-	S
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=480\text{V}$ , $V_{\text{GS}}=0\text{V}$	-	-	25	$\mu\text{A}$
	Drain-Source Leakage Current ( $T_j=125^\circ\text{C}$ )	$V_{\text{DS}}=480\text{V}$ , $V_{\text{GS}}=0\text{V}$	-	-	250	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage	$V_{\text{GS}}=\pm 30\text{V}$	-	-	$\pm 100$	nA
$Q_g$	Total Gate Charge	$I_D=10\text{A}$	-	34	57	nC
$Q_{\text{gs}}$	Gate-Source Charge		-	11	-	nC
$Q_{\text{gd}}$	Gate-Drain ("Miller") Charge		-	11	-	nC
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DD}}=300\text{V}$	-	19	-	ns
$t_r$	Rise Time	$I_D=10\text{A}$	-	28	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time		-	43	-	ns
$t_f$	Fall Time		-	22	-	ns
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}}=0\text{V}$	-	2030	3250	pF
$C_{\text{oss}}$	Output Capacitance	$V_{\text{DS}}=25\text{V}$	-	225	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance	f=1.0MHz	-	9	-	pF

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{\text{SD}}$	Forward On Voltage <sup>3</sup>	$I_S=10\text{A}$ , $V_{\text{GS}}=0\text{V}$	-	-	1.5	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_S=10\text{A}$ , $V_{\text{GS}}=0\text{V}$ ,	-	600	-	ns
$Q_{\text{rr}}$	Reverse Recovery Charge	dl/dt=100A/ $\mu\text{s}$	-	12	-	uC

### Notes:

1. Pulse width limited by Max. junction temperature.
2. Starting  $T_j=25^\circ\text{C}$ ,  $V_{\text{DD}}=50\text{V}$ ,  $L=1.0\text{mH}$ ,  $R_G=25\Omega$ ,  $I_{\text{AS}}=10\text{A}$ .
3. Pulse test

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

APEC RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN.

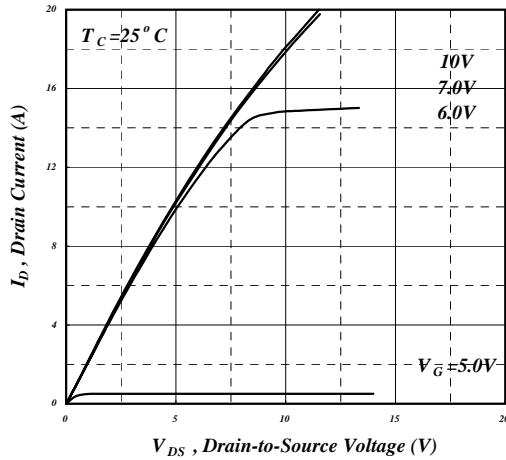


Fig 1. Typical Output Characteristics

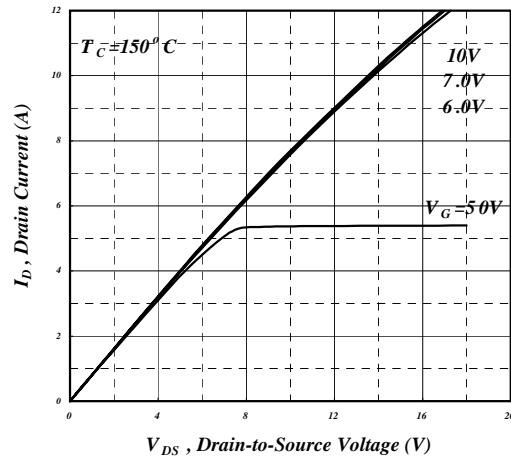


Fig 2. Typical Output Characteristics

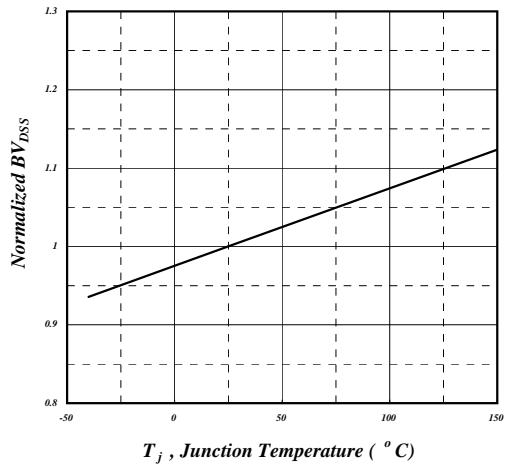
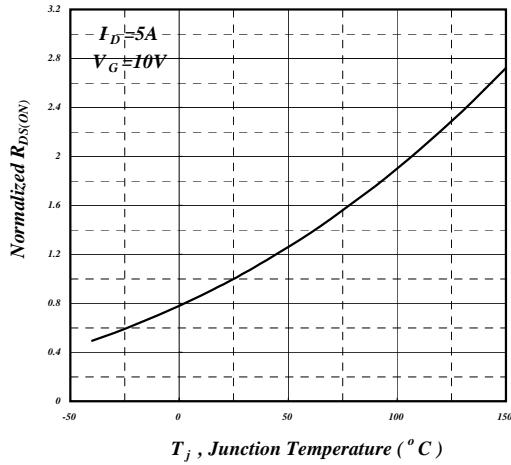
Fig 3. Normalized  $BV_{DSS}$  v.s. Junction Temperature

Fig 4. Normalized On-Resistance v.s. Junction Temperature

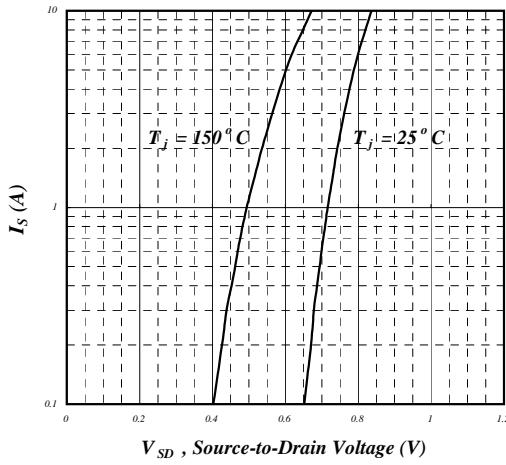


Fig 5. Forward Characteristic of Reverse Diode

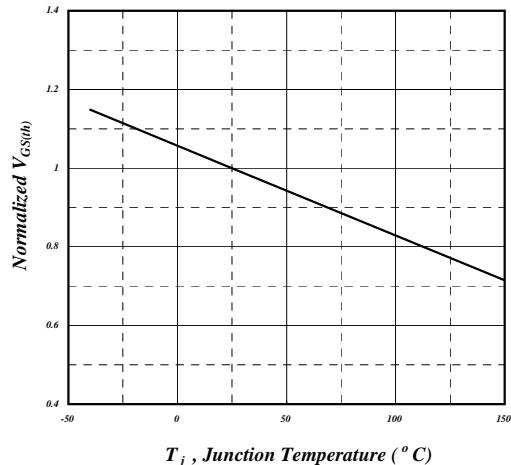
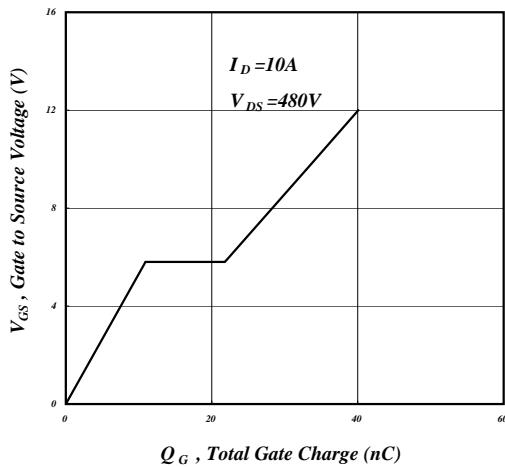
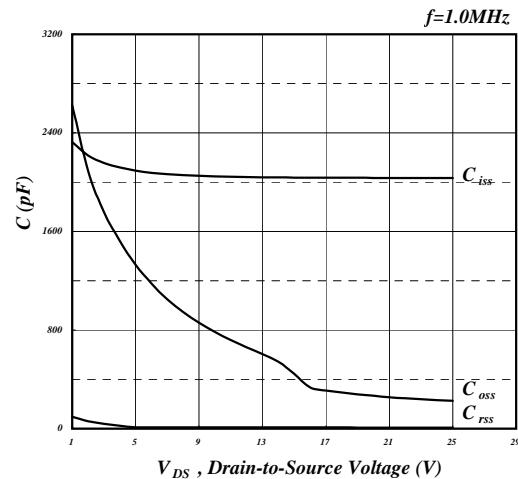


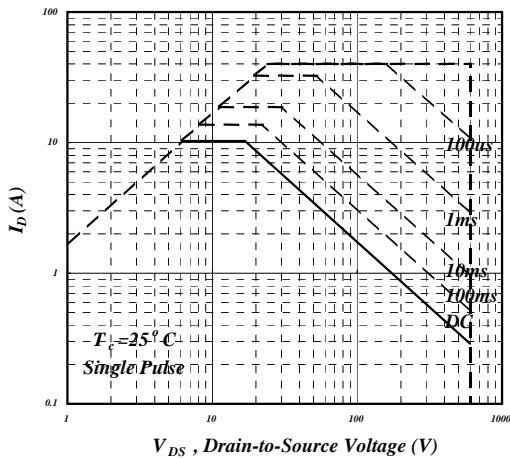
Fig 6. Gate Threshold Voltage v.s. Junction Temperature



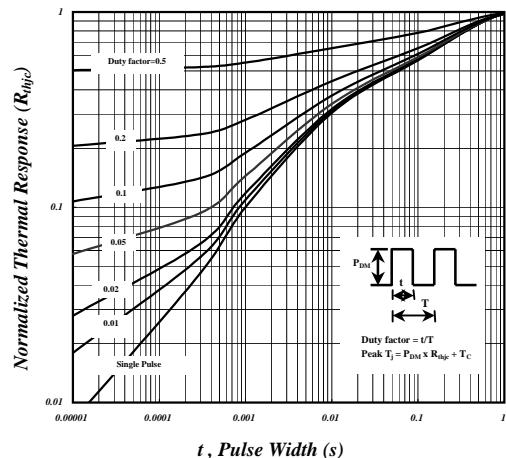
**Fig 7. Gate Charge Characteristics**



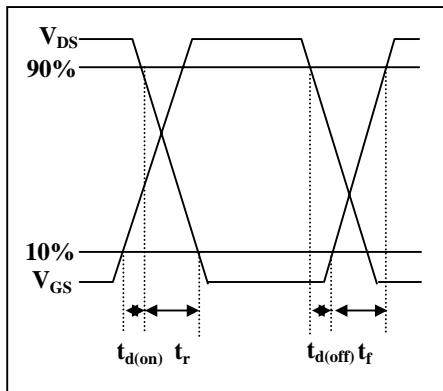
**Fig 8. Typical Capacitance Characteristics**



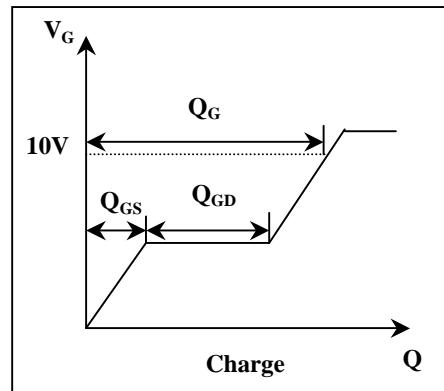
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Waveform**

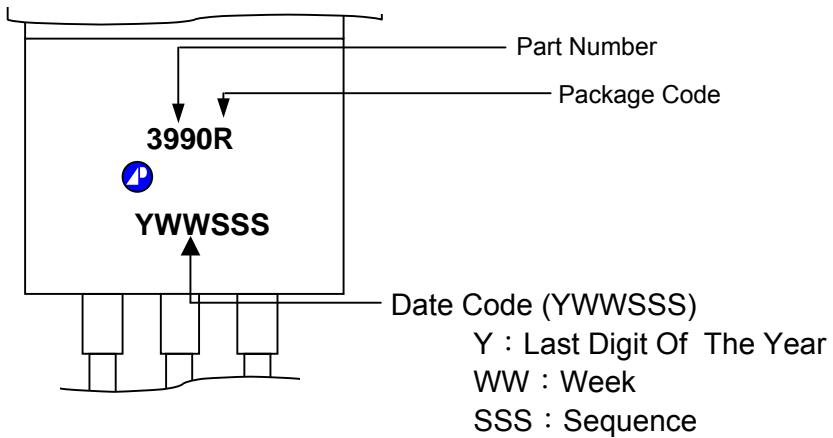


**Fig 12. Gate Charge Waveform**



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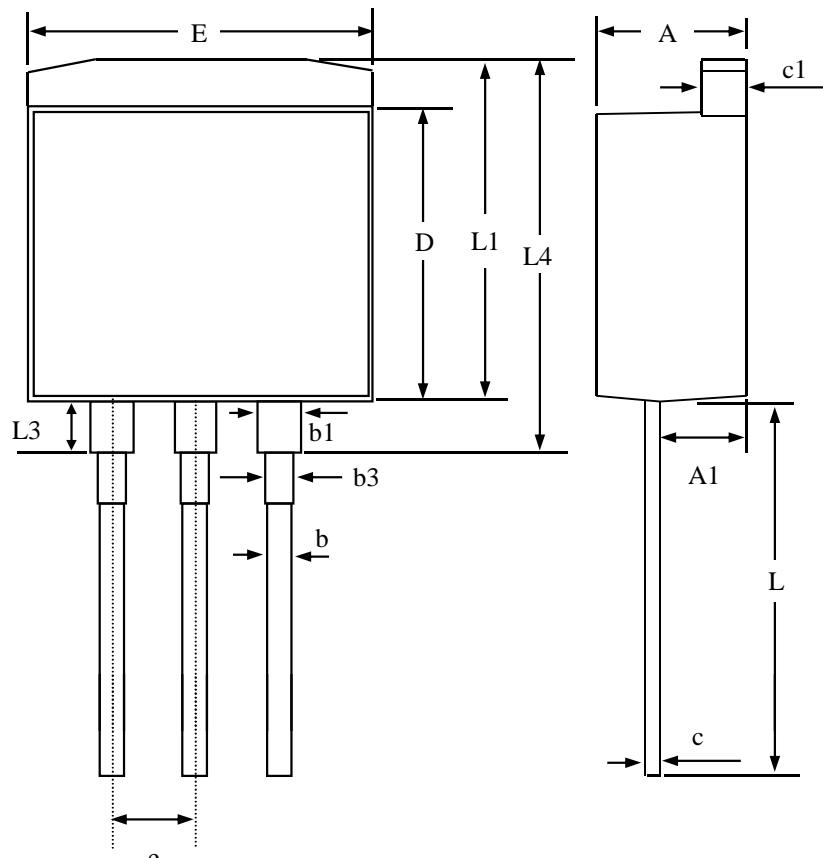
## **MARKING INFORMATION**





ADVANCED POWER ELECTRONICS CORP.

## Package Outline : TO-262



SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	4.24	4.54	4.84
A1	2.10	2.50	2.90
b	0.65	0.85	1.05
b1	0.63	1.08	1.53
b3	0.75	1.08	1.40
c	0.30	0.45	0.60
c1	1.15	1.3	1.45
D	8.30	8.9	9.50
E	9.50	10	10.50
e	2.04	2.54	3.04
L	10.50	12.5	14.50
L1	8.50	10	11.50
L3	1.3 ~ 4.8 (ref)		

1. All Dimensions Are in Millimeters.

2. Dimension Does Not Include Mold Protrusions.

Draw No. M1-R3-G-v05



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**TO-262 FOOTPRINT :**

